

			02.11.2011
RefMat No	12		Category 1 Nano Objects / Nanopart
	COMAR	Included in	Category 2
	C	OMAR Database: Green 1> YES	Category 3
	\$ \\ \\ \\ \\ \\ \\ \\ \\ \\ \\ \\ \\ \\	Blue 0> NO	Category 4
Type_of_RefMa	t: RM		Category 5
Name of RM: A	bsolute Contamination Stand	dard (ACS)	
· · · · · · · · · · · · · · · · · · ·	e Contamination Standards		
wafer; s	ene Latex Spheres on Si; phere diameter,		
	ration; 40 nm; calibrate instruments which size a	nd detect particle	es on the surface of bare silicon wafers
Link http://w	ww.vlsistandards.com/products/contami	nation/absolute.asp	?SID=23
	Certified (Qantities	
	sphere diameter	MeanValue	40 nm Uncertainty
	concentration	MeanValue	nm Uncertainty
	size distribution	MeanValue	nm Uncertainty
		MeanValue Management	nm Uncertainty
J		MeanValue	nm Uncertainty
Calibration of	Size distribution of particles		Characterised by
Calibration of	Particle counters		Characterised by
Calibration of			Characterised by
Calibration of			Characterised by
Calibration of			Characterised by
2 Provider		Prov	rider No 3
Provider No	Web address http	o://www.vlsistanda	ards.com
Provider	VLSI Standards, Inc.		
Contact Person	Marc Helvey, ext. 108	Country	USA
Email	sales.support@vlsistd.com	City	San Jose
Phone	(408) 428-1800	City Code	CA 95134-2006
		Street + No	3087 North First Street